



# Analysis and Optimization of Organic Tandem Solar Cells by Full Opto-Electronic Simulation

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This paper reports on the analysis and optimization of high-efficiency organic tandem solar cells via full opto-electronic device simulation on continuum level and using a hopping model for the explicit description of the charge recombination junction. Inclusion of the electrical sub-cell interconnection allows for a rigorous assessment of the impact of the internal charge distribution and associated built-in fields as well as quasi-Fermi level profiles on the measured device characteristics. It enables the direct evaluation of the external quantum efficiency in a simulation that follows closely the measurement protocol, and sheds light on complications related to the dependence of the band profile on the illumination conditions. The study also points at fingerprints of insufficient junction quality in the electrical characteristics of the tandem device. After studying the impact of key electrical parameters such as, carrier mobility, lifetime and interface hopping rate, onto the device characteristics, the latter are optimized not only optically, but also electronically, adding in both cases an increasing number of layers to the parameters of the global optimization procedure. An improvement of 2% absolute power conversion efficiency by using the full opto-electronic optimization as compared to optical optimization only is found.

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## 1 INTRODUCTION

With the demonstration of solar energy conversion efficiencies close to 20% (Wang et al., 2021a), organic photovoltaics (OPV) has recently confirmed its potential for a low cost, flexible and versatile technology for renewable energy supply. These high efficiencies were achieved using a tandem concept, in which two absorber materials with different band gaps are stacked to make better use of the solar spectrum. In fact, due to the prospect of higher conversion efficiencies and larger range of open circuit voltages achievable as compared to single junction technology, multi-junction architectures have become an important focus of organic solar cell research (Ameri et al., 2009; Ameri et al., 2013; Di Carlo Rasi and Janssen, 2019; Zhang et al., 2020). As in the industrially more relevant two-terminal configuration current matching is required to achieve maximum efficiency, the geometry and composition of the complex multi-layer stacks needs to be adjusted carefully. For this task, optical simulations of the absorption within the individual sub-cells were shown to be instrumental (Li et al., 2017; Lingxian et al., 2018; Wang et al., 2021a; Liu et al., 2021). However, small variations in layer thicknesses can have significant impact on charge carrier extraction in low-

mobility and defect-rich organic materials, and, hence, on the specifics of the optimum tandem configuration (Tress, 2014). Most importantly, the design of the charge recombination layer connecting the two sub-cells is critical for the performance of the tandem device (Aeberhard et al., 2019; Wang et al., 2021b). The present work intends to assess this impact computationally via full opto-electronic simulation and optimization of the organic tandem solar cell device. To this end, a recently developed interface hopping model describing the charge transfer at the recombination junction (Altazin et al., 2018a) is combined with the standard coupled optical and drift-diffusion-Poisson solvers for organic solar cells, as implemented in the device simulation software Setfos (Fluxim, 2022).

The paper is organized as follows. In **Section 2**, the physical models and the simulation procedure are briefly reviewed, covering also the approaches for interface hopping and the numerical optimization. In **Section 3**, the organic tandem solar cell system considered is described in terms of initial geometry and material composition of the layer stack, including a discussion about the extraction of material parameters used. **Section 4** provides a detailed discussion of the numerical simulation results, from the analysis of single junction and tandem characteristics—with special focus on the extraction of the tandem external quantum efficiency (EQE)—to the optical and electrical optimization. A brief summary and the main conclusions are given in **Section 5**.

## 2 SIMULATION APPROACH

The simulations of the organic tandem solar cells are performed using the Setfos tool developed by Fluxim AG, which solves the macroscopic semiconductor transport equations—charge carrier continuity equations with drift-diffusion current coupled to Poisson's equation for the electrostatic potential (Häusermann et al., 2009; Knapp et al., 2010)—for a quasi-1D problem together with a 1D model for coherent and incoherent light propagation in multi-layer structures based on transfer matrix and net radiation methods (Lanz et al., 2011; Santbergen et al., 2013). Originally developed for the simulation of organic light emitting devices (OLED) (Ruhstaller et al., 2003), Setfos includes advanced mobility models for disordered organic materials, and the physical models implemented have been validated with a broad range of experimental characterization experiments in the fields of OPV (Neukom et al., 2018) and OLED (Jenatsch et al., 2020).

As stated above, the central equations that are solved are the continuity equations for mobile and trapped electron and hole densities  $n$ ,  $p$ , and  $n_b$ ,  $p_b$ , respectively:

$$\frac{\partial}{\partial t} n(z, t) = -\frac{1}{q} \frac{\partial}{\partial z} J_n(z, t) + \mathcal{G}(z, t) - \mathcal{R}_{nt}(z, t) - \mathcal{R}_{np}(z, t), \quad (1)$$

$$\frac{\partial}{\partial t} p(z, t) = \frac{1}{q} \frac{\partial}{\partial z} J_p(z, t) + \mathcal{G}(z, t) - \mathcal{R}_{pt}(z, t) - \mathcal{R}_{np}(z, t), \quad (2)$$

$$\frac{\partial}{\partial t} n_t(z, t) = \mathcal{R}_{nt_n}(z, t) - \mathcal{R}_{pt_n}(z, t) - \mathcal{R}_{t_n t_p}(z, t), \quad (3)$$

$$\frac{\partial}{\partial t} p_t(z, t) = -\mathcal{R}_{nt_p}(z, t) + \mathcal{R}_{pt_p}(z, t) - \mathcal{R}_{t_n t_p}(z, t). \quad (4)$$

In the above equations,  $t$  is the time,  $z$  the coordinate along which transport is assumed to proceed,  $q$  is the elementary electronic charge,  $J_{n(p)}$  is the electron (hole) current density, is the (optical) volume generation rate, and  $\mathcal{R}_{np}$  is the rate of bi-molecular inter-band recombination. The remaining rate terms describe the various processes of the charge carrier trapping dynamics, where the total electron (hole) trapping volume rate is  $\mathcal{R}_{nt} = \mathcal{R}_{nt_n} + \mathcal{R}_{nt_p}$  ( $\mathcal{R}_{pt} = \mathcal{R}_{pt_p} + \mathcal{R}_{pt_n}$ ) and  $\mathcal{R}_{t_n t_p}$  is the trap-trap recombination rate. In this work, to keep the complexity of the model on a manageable level, excitons are not treated explicitly—as would be possible in Setfos—but photogeneration is expressed directly via  $G = A \cdot \eta_{\text{gen}}$  in terms of the local absorption rate  $A$  (obtained from the optical model) and a generation efficiency  $\eta_{\text{gen}}$ . Furthermore, recombination is restricted to the Shockley-Read-Hall channel—i.e., bi-molecular and trap-trap terms are neglected—and only single defect levels close to mid-gap position are considered, which are treated as deep electron traps. For the currents in **Eqs 1, 2**, the standard drift-diffusion form is assumed,

$$J_n(z, t) = q\mu_n(z, t) \left[ n(z, t)\mathcal{E}(z, t) + \frac{k_B T}{q} \frac{\partial}{\partial z} n(z, t) \right], \quad (5)$$

$$J_p(z, t) = q\mu_p(z, t) \left[ p(z, t)\mathcal{E}(z, t) - \frac{k_B T}{q} \frac{\partial}{\partial z} p(z, t) \right], \quad (6)$$

where the Einstein relation was used to replace the diffusion constant by the charge carrier mobility  $\mu$ , and the electric field  $\mathcal{E}$  is obtained from the solution of Poisson's equation:

$$\begin{aligned} \epsilon_0 \frac{\partial}{\partial z} [\epsilon_r(z)\mathcal{E}(z, t)] = q [p(z, t) - n(z, t) + p_t(z, t) - n_t(z, t) \\ + N_{\text{don}}(z) - N_{\text{acc}}(z)], \end{aligned} \quad (7)$$

where  $\epsilon_0$  is the vacuum permittivity,  $\epsilon_r$  is the relative dielectric constant, and  $N_{\text{acc}}$  ( $N_{\text{don}}$ ) is the density of ionized acceptor (donor) molecules. In organic semiconductors, the charge carrier mobilities in (5) and (6) may also depend on the local field, in which case a Poole-Frenkel-type expression is used (Frenkel, 1938):

$$\mu_{n,p} = \mu_{0n,p} \exp(\gamma_{n,p} \sqrt{|\mathcal{E}|}), \quad \gamma_{n,p} = 1 / \sqrt{\epsilon_{0n,p}}. \quad (8)$$

Finally, the charge carrier densities are related via Boltzmann occupation statistics to the effective density of states  $N_{0n,p}$ , the HOMO/LUMO energies (including the electrostatic potential profile), and the quasi-Fermi levels  $EF_{n,p}$  through,

$$n(z, t) = N_{0n}(z) \exp\left(\frac{EF_n(z, t) - \text{LUMO}(z, t)}{k_B T}\right), \quad (9)$$

$$p(z, t) = N_{0p}(z) \exp\left(-\frac{EF_p(z, t) - \text{HOMO}(z, t)}{k_B T}\right). \quad (10)$$

While Setfos provides solutions of the above equations also in the transient case, the current investigation is restricted to the stationary state, for which any time dependence vanishes. In that case, the trap-mediated inter-band recombination rate for a single defect level at energy  $E_t$  (measured from the conduction band minimum) with density  $N_t$ , can be expressed *via* the Shockley-Read-Hall formalism (Hall, 1952; Shockley and Read, 1952):

$$\begin{aligned} \mathcal{R}_{nt}(z) &= \mathcal{R}_{pt}(z) \equiv \mathcal{R}_{SRH}(z) \\ &= \frac{[n(z)p(z) - n_i^2(z)]}{C_p^{-1}[n(z) + n_{t0}(z)] + C_n^{-1}[p(z) + p_{t0}(z)]}, \end{aligned} \quad (11)$$

where  $C_{n,p}$  are the electron and hole capture rates,

$$n_{t0}(z) = N_{0n}(z) \exp\left(\frac{E_t(z) - \text{LUMO}(z)}{k_B T}\right), \quad (12)$$

$$p_{t0}(z) = N_{0p}(z) \exp\left(-\frac{E_t(z) - \text{HOMO}(z)}{k_B T}\right), \quad (13)$$

$$n_i^2(z) = N_{0n}(z)N_{0p}(z) \exp\left(-\frac{E_g(z)}{k_B T}\right), \quad (14)$$

and

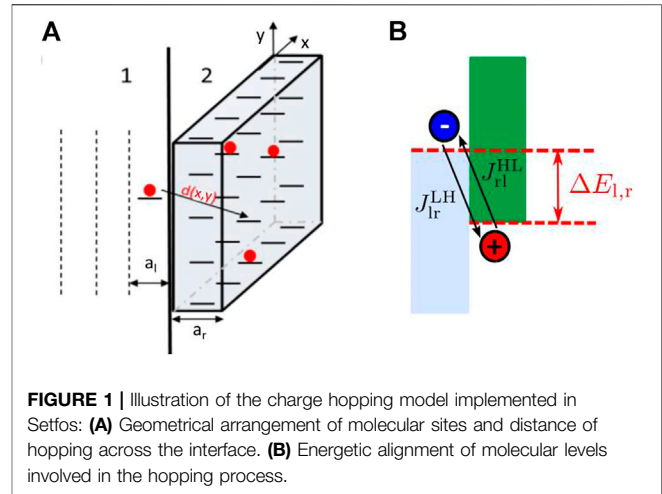
$$E_g(z) = \text{LUMO}(z) - \text{HOMO}(z) \quad (15)$$

Solution of the steady-state drift-diffusion-Poisson problem requires application of appropriate boundary conditions for the charge carrier densities and the electric field. For the latter, the total potential drop over the device thickness  $L$  is equated to the difference of applied and built-in potentials,

$$\int_0^L dz \mathcal{E}(z) = V_{\text{app}} - V_{\text{bi}}, \quad (16)$$

where the built-in potential is inferred from the top and bottom electrode work functions,  $qV_{\text{bi}} = \Phi_{\text{top}} - \Phi_{\text{bot}}$ . For the charge carrier densities, ohmic contacts correspond to a Dirichlet boundary condition defined *via* the electrode work functions and Exprs. (9) and (10), while thermionic injection is considered using the model of (Scott and Malliaras, 1999) that fixes the injection currents as a (complex) function of carrier mobility, HOMO-LUMO levels, work function, effective density of states, dielectric constant, electric field, and temperature. In order to enable consideration of non-ideal contacts with finite shunt and series resistances  $R_{\text{SH}}$  and  $R_s$ , the drift-diffusion model is coupled to an external circuit model containing those resistive elements.

A key feature that enables the electrical simulation of tandem devices with Setfos is the hopping interface model (Altazin et al., 2018b), as it can be used to describe the charge transfer between the monolithically integrated sub-cells. In this model, that is based on the Miller-Abrahams theory of thermally activated hopping in disordered materials (Miller and Abrahams, 1960; Coropceanu et al., 2007), the individual rates for charge transfer can be specified for intra- as well as



**FIGURE 1** | Illustration of the charge hopping model implemented in Setfos: **(A)** Geometrical arrangement of molecular sites and distance of hopping across the interface. **(B)** Energetic alignment of molecular levels involved in the hopping process.

interband transitions. For the tandem OPV simulations, only HOMO-LUMO transfer is considered, i.e., the junction is assumed to be ideal with respect to leakage currents. The rate of interband hopping connecting the HOMO on the left side with the LUMO on the right side of the interface is then given by (Altazin et al., 2018b)

$$T_{lr}^{LH}(p_r) = a_r p_r \nu \exp\left(-\frac{|\Delta E_{lr}| + \Delta E_{l,r}}{2k_B T}\right) \quad (17)$$

with

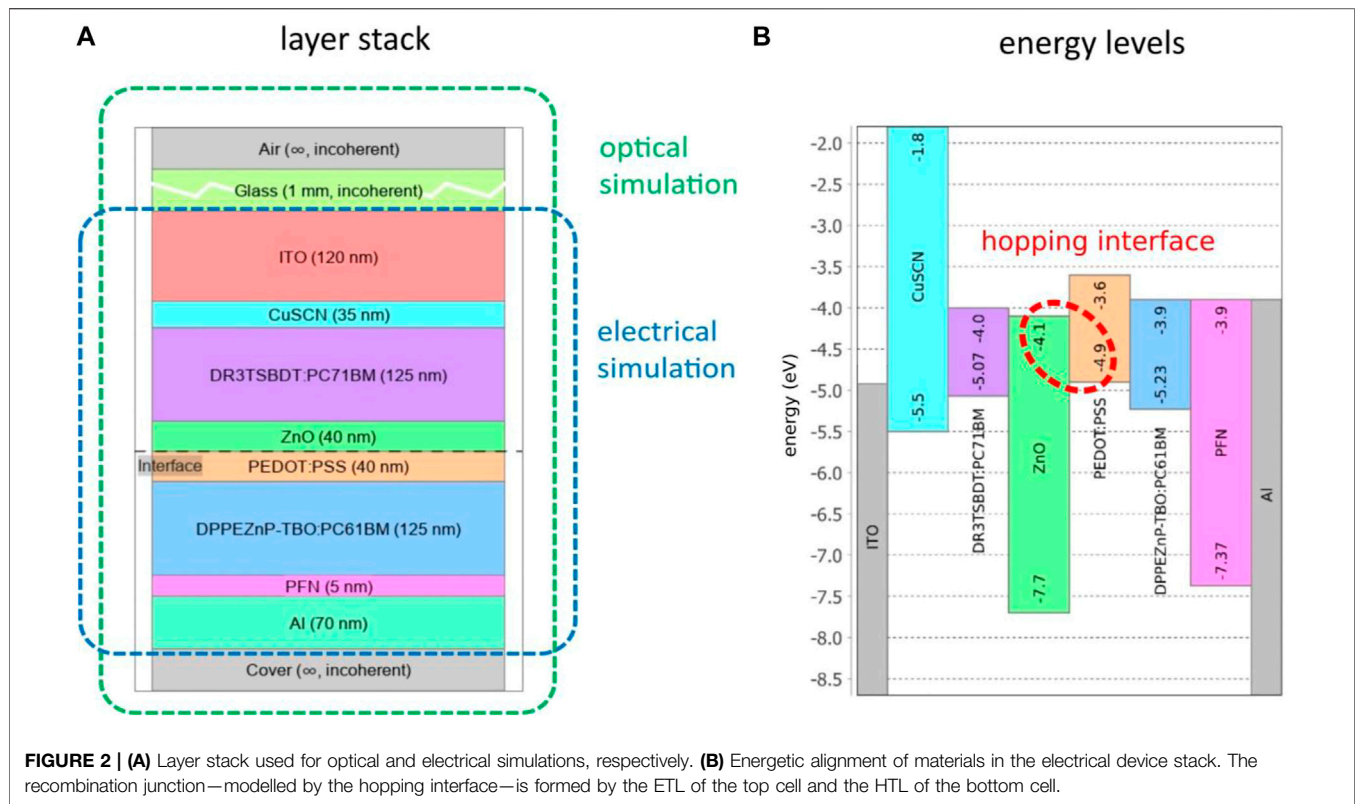
$$\nu = \nu \int dx \int dy \exp[-\gamma d(x,y)]. \quad (18)$$

In the above expressions,  $p_r$  and  $a_r$  are hole density and molecular lattice spacing of the right side,  $\nu$  is the attempt frequency of the hopping process (in units of  $\text{m}^2 \text{s}^{-1}$ ),  $d(x,y) = [(a_l + a_r)^2/4 + x^2 + y^2]^{1/2}$  is the hopping distance,  $\gamma$  is the inverse tunneling distance, and  $\Delta E_{l,r}$  is the energy difference between the left and right molecular states involved in the hopping process (see also **Figure 1** for an illustration of the hopping model). The associated tunneling particle current density is

$$J_{lr}^{LH}(n_l, p_r) = a_l n_l T_{lr}^{LH}(p_r), \quad (19)$$

where  $n_l$  and  $a_l$  are now the electron density and molecular lattice spacing on the left side of the interface. Integration into the conventional drift-diffusion-Poisson framework for classical continuum charge transport simulation is then achieved by matching the tunneling current with the drift-diffusion currents on either side of the interface.

A further feature of the software Setfos that is used in this work regards the optimization routines. A combination of global and local optimization algorithms is applied to different targets, such as fitting of current-voltage (JV) curves for the extraction of material parameters, and layer thickness optimization of tandem OPV devices for maximum performance based on optical and coupled opto-electronic simulation. For the optical assessment of tandem solar cells, the minimum of the sub-cell photocurrents is maximised. Since the global optimum configuration is achieved



in the regime where enhancing the photocurrent in the top cell results in a decrease of the bottom cell current, maximum performance corresponds to the situation of current matching. For the opto-electronic optimization, the photovoltaic power conversion efficiency (PCE) of the tandem device is set directly as the optimization target.

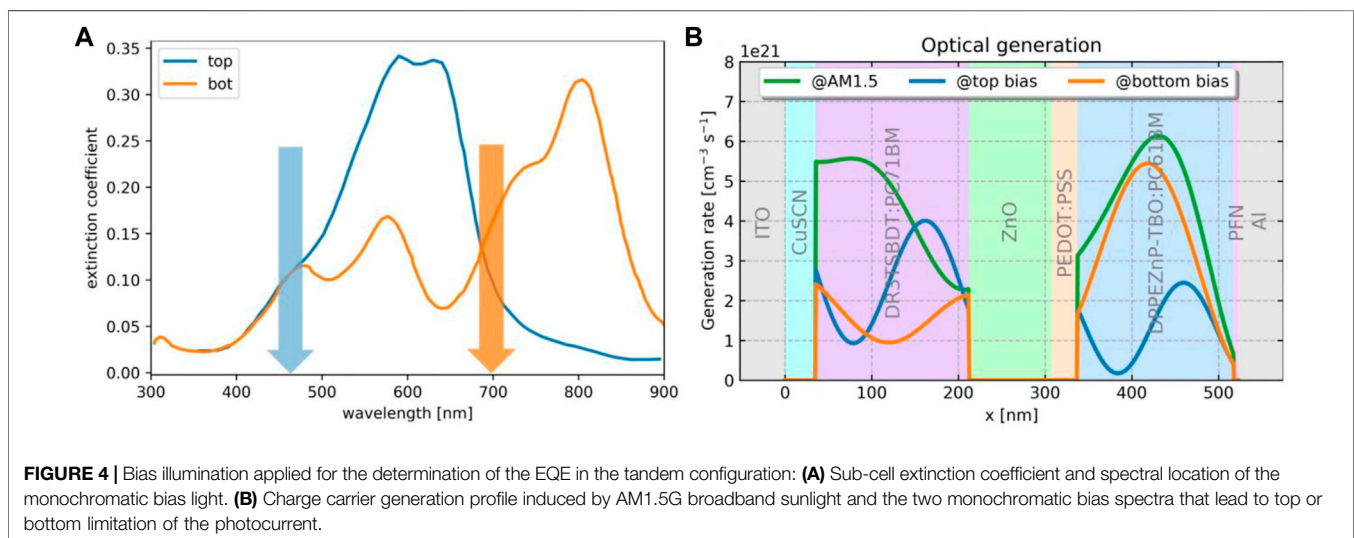
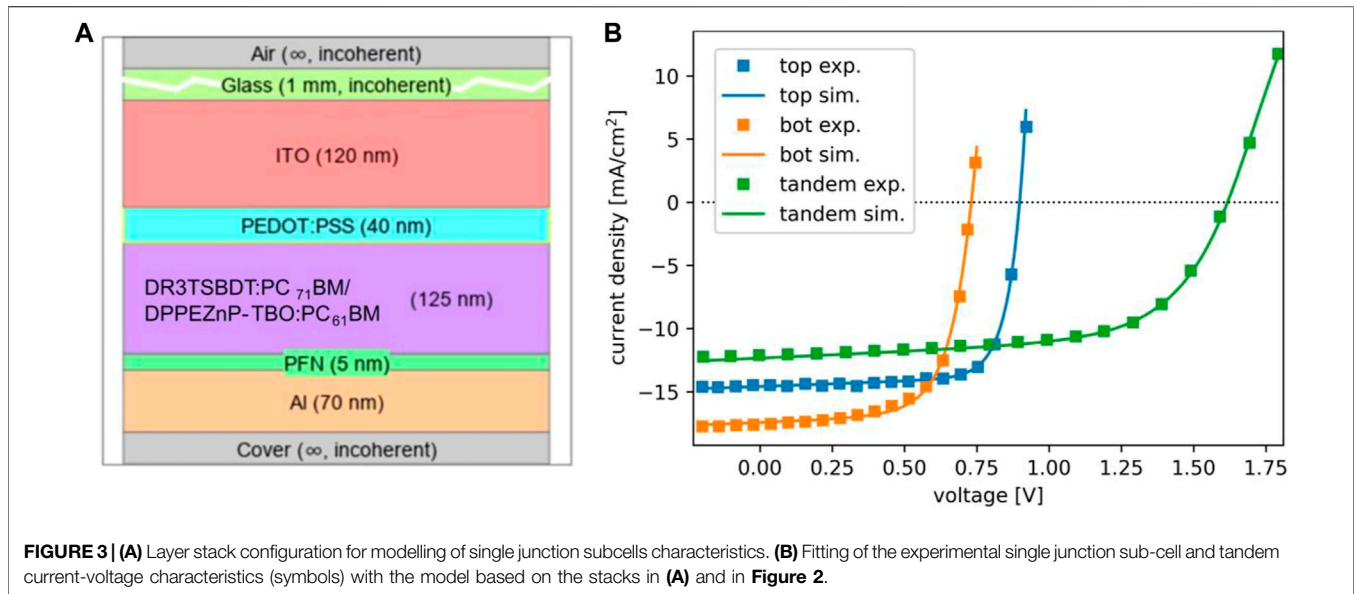
### 3 IMPLEMENTATION

For the simulation of organic tandem solar cells, we consider the high-efficiency device architecture described in Ref. (Li et al., 2017), consisting of a top cell with a DR3TSBDT:PC<sub>71</sub>BM absorber layer and a bottom cell based on a DPPEZnP-TBO:PC<sub>61</sub>BM absorber, connected by a recombination interlayer composed of a combination of ZnO nano-particles and PEDOT:PSS. Thin layers of CuSCN and PFN are used as electron and hole blocking layers at anode and cathode, respectively. The electrodes are formed by ITO and Al. The layer structure and the energy level alignment of the experimental model system used for the simulation are displayed in **Figure 2**. For the initial layer thicknesses, the values are taken again from Ref. (Li et al., 2017), with the exception of the glass at the top electrode, which is set to 1 mm. Accordingly, the glass substrate is treated as an incoherent layer in the optical simulation. For the electrical simulation, the intrinsic values for HOMO-LUMO levels are taken as indicated in Ref. (Li et al., 2017), and electron and

hole transport levels of the individual bulk heterojunctions of the sub-cells are identified as displayed in **Figure 2B**. The single junction solar cells were implemented following the experimental realization in Ref. (Li et al., 2017), i.e., both absorber materials were sandwiched between PEDOT:PSS as hole transport layer (HTL) and a PFN/Al contact. At the ITO contact, hole injection is modelled *via* thermionic boundary conditions, while the PFN/Al contact is assumed to be ohmic. For injection of holes into PEDOT:PSS, the ITO work function is set at the standard value of 4.7 eV, while a larger WF of 4.97 eV is used in the case of injection into CuSCN in order to consider the lower effective injection barrier due to the presence of band tails (Kim et al., 2016).

Additionally, a series resistance of 1.2  $\Omega \text{ cm}^2$  is assumed for the top cell in single junction configuration, while a shunt resistance of 1.6 k $\Omega \text{ cm}^2$  is used for all cells.

While the optical material parameters (*nk*-data) and charge carrier mobilities were taken from the literature 9CuSCN: (Pattanasattayavong et al., 2015; Ezealigo et al., 2020), DR3TSBDT: (Kumari et al., 2017), DPPEZnP-TBO: (Xiao et al., 2017), PFN: (He et al., 2012)], the recombination parameters are adjusted using global multi-parameter optimization routines (dividing rectangles algorithm) to fit the experimental single junction and tandem device characteristics given in (Li et al., 2017). For the tandem simulation, the single junction material parameters are used except for the defect densities in the absorber layers, which are taken as starting values to obtain the defect densities in the tandem configuration. For the effective attempt frequency of



the charge hopping at the recombination junction, a value of  $\mathcal{V} = 5 \times 10^{-5} \text{ m}^2/\text{s}$  is chosen. Based on these settings, a good fit of all the JV curves could be achieved with a consistent parameter set, as displayed in **Figure 3**. All of the optical and electrical parameters used in the simulation of the single junction and tandem devices are given in the **Supplementary Material**.

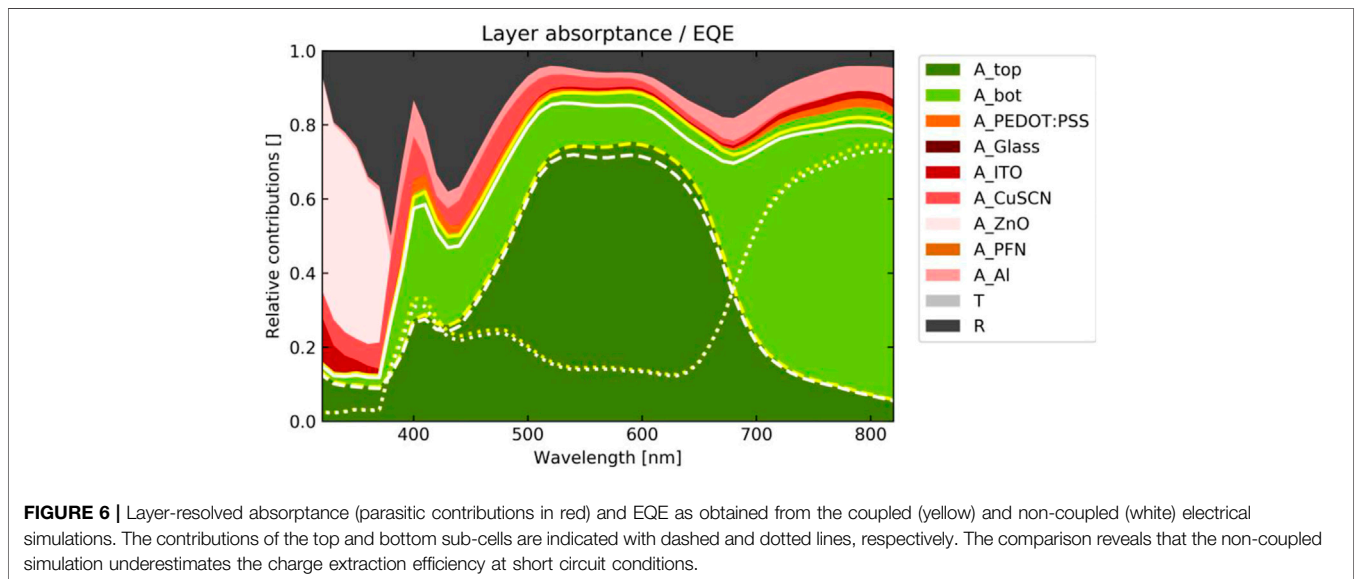
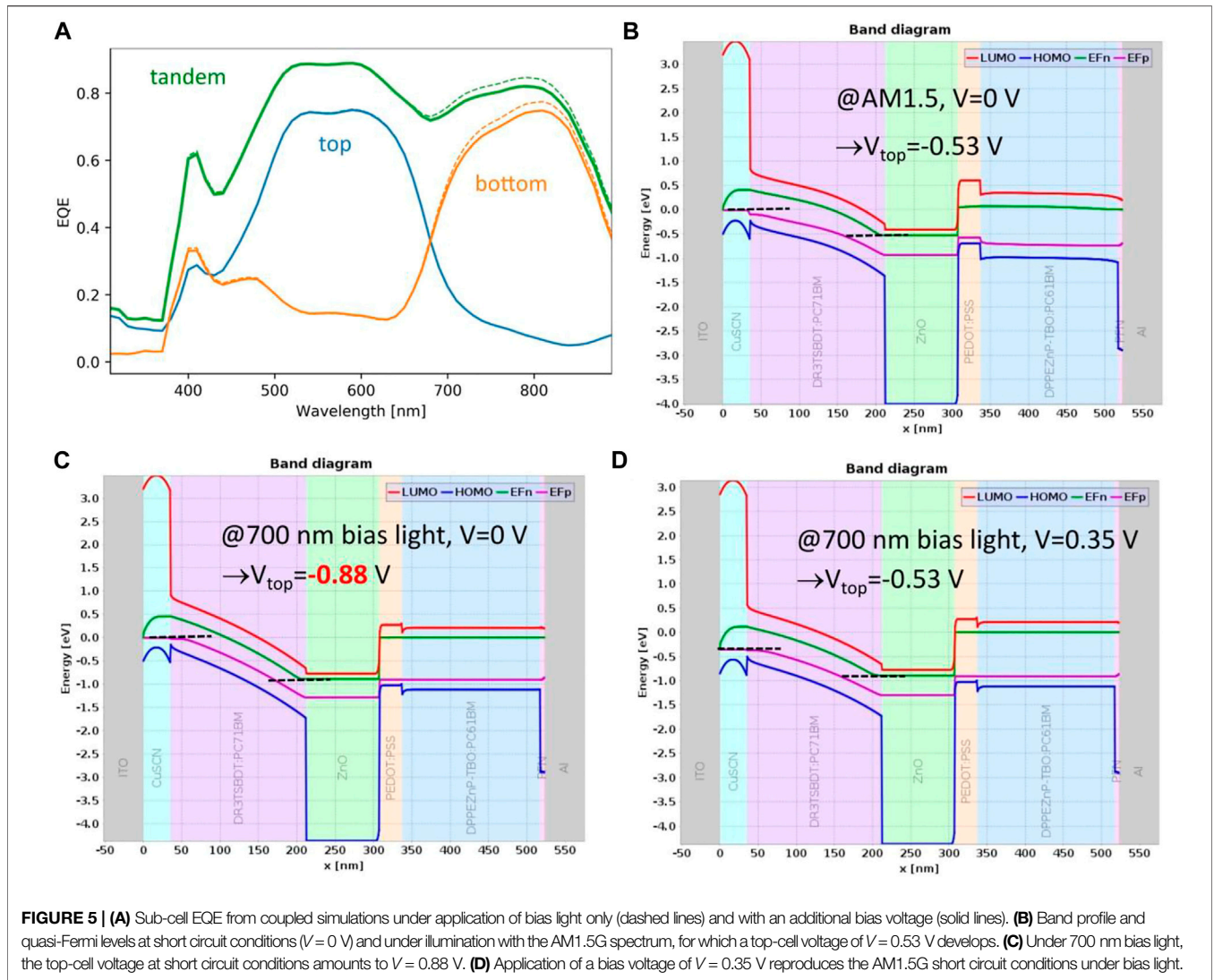
The spectrum considered for solar illumination is the ASTM G173-03 (Terrestrial “Global Tilt” AM1.5) reference spectrum from <http://rredc.nrel.gov/solar/spectra/am1.5/>, which will be referred to as AM1.5G in the following. Due to lack of accurate  $nk$ -data for the absorber layers, the generation rate had to be scaled (via  $\eta_{\text{gen}}$ ) in order to reproduce the AM1.5G short circuit current given in Ref. (Li et al., 2017) for the reference geometry. For the same

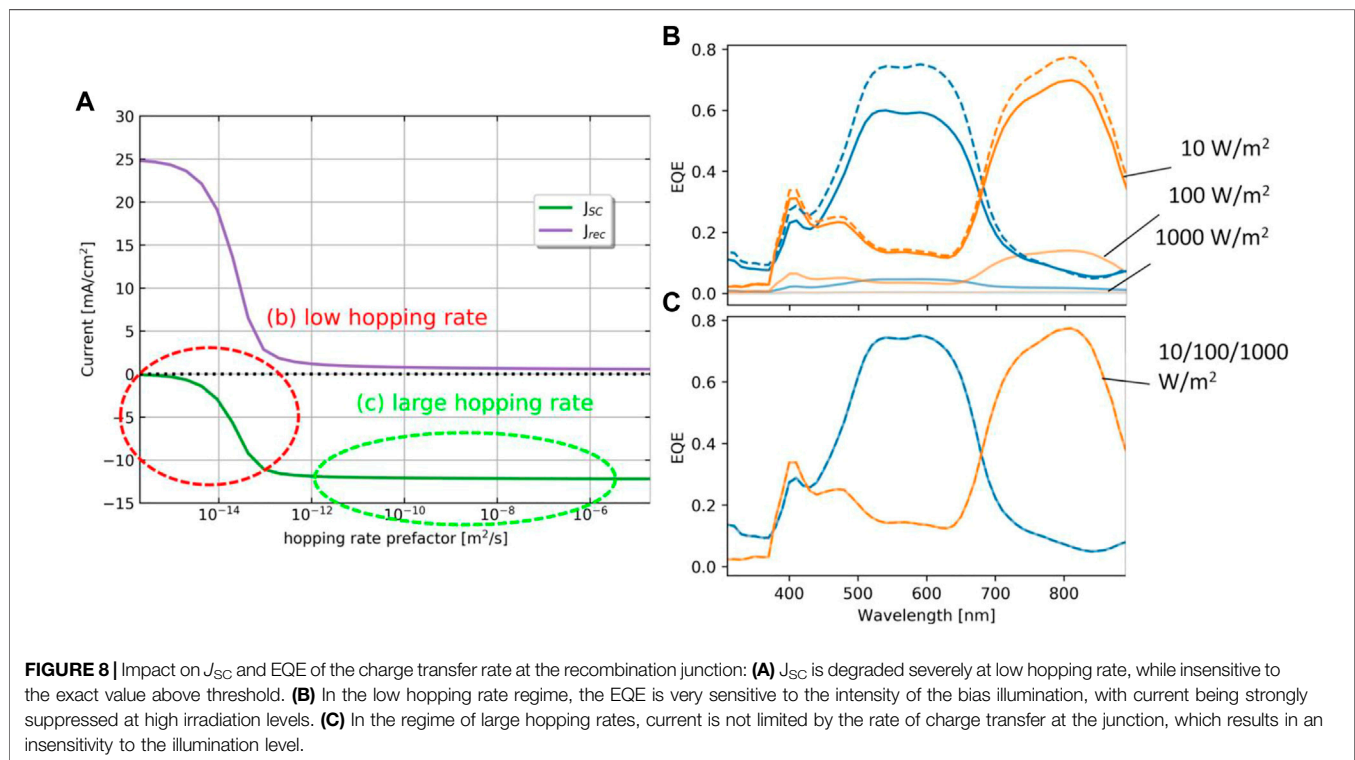
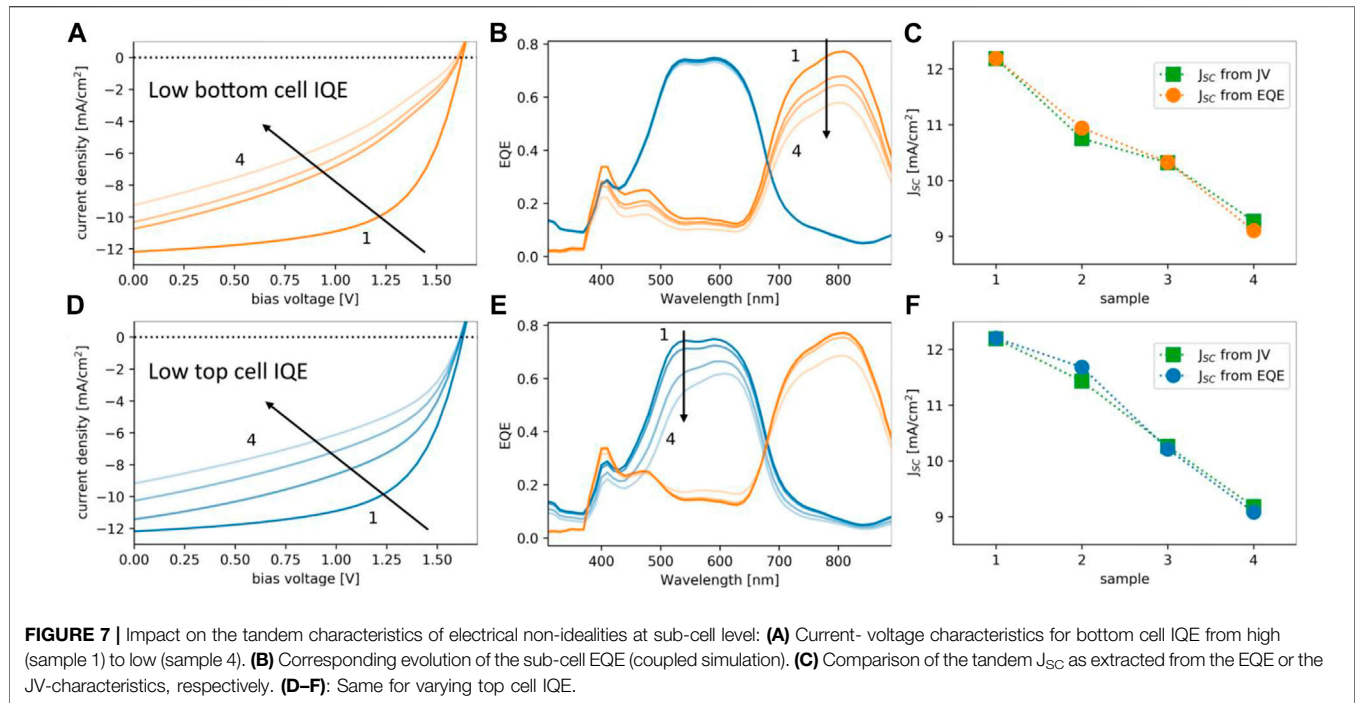
reason, the experimental EQE data was not used in the parameter extraction.

## 4 NUMERICAL RESULTS

### 4.1 Analysis of Single Junction and Tandem Characteristics

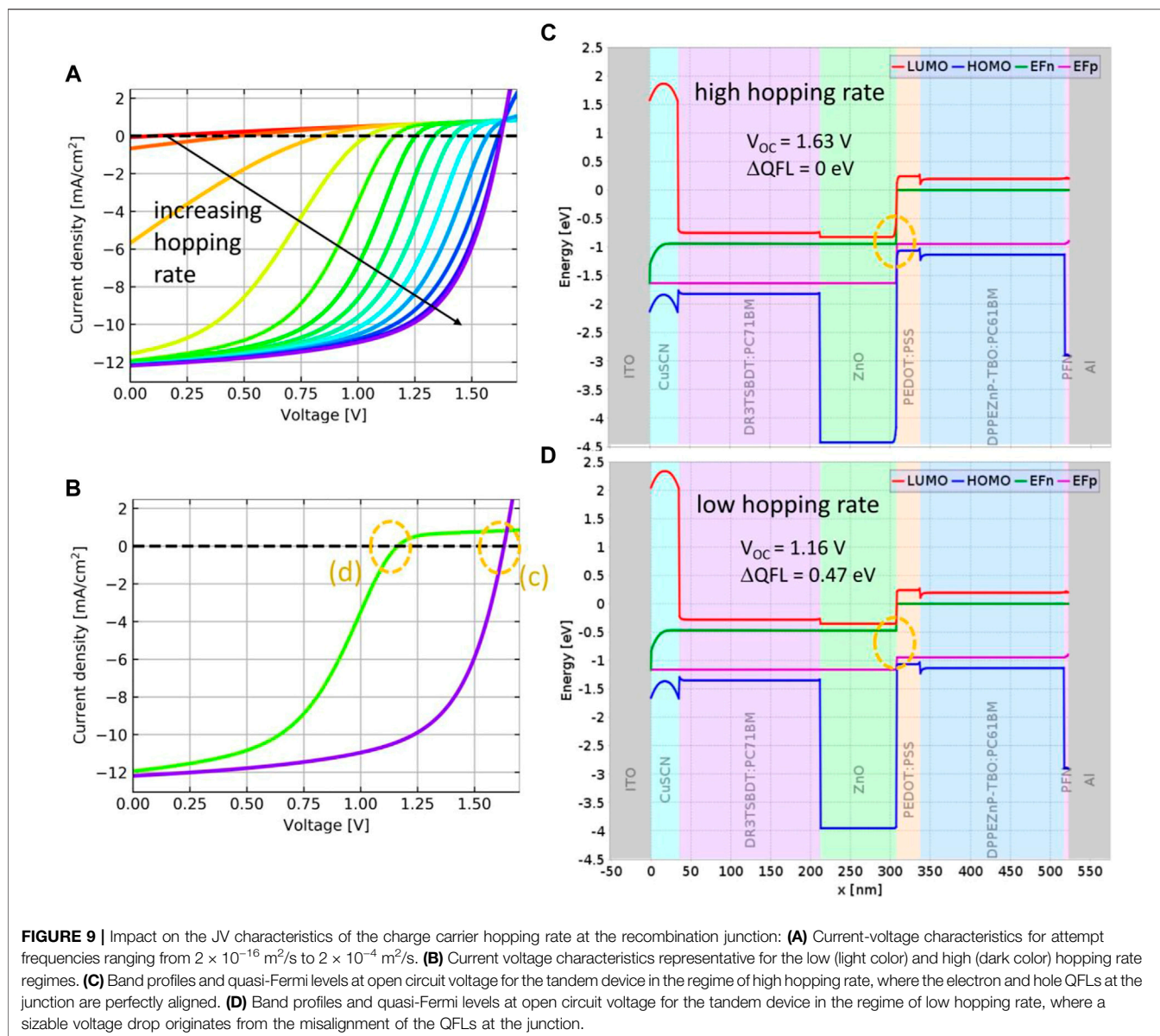
Identification and analysis of electrical losses starts with the comparison of the external quantum efficiency (EQE) with the absorbance. However, the proper determination of the EQE of organic tandem devices is not straightforward, as was realized over a decade ago (Gilot et al., 2010; Gilot et al., 2011). Of course, the main complication—common to all tandem devices—arises from the fact that in order to probe a specific sub-cell, this one





needs to be current limiting over the whole range of wavelengths, which requires appropriate *bias illumination*. For organic devices there is the additional problem that the carrier extraction efficiency depends strongly on the built-in field which, in turn,

changes with illumination. This requires the additional application of a *bias voltage* to establish the conditions found under AM1.5G illumination at global short circuit conditions. Only in this case will the extracted EQE provide the measured

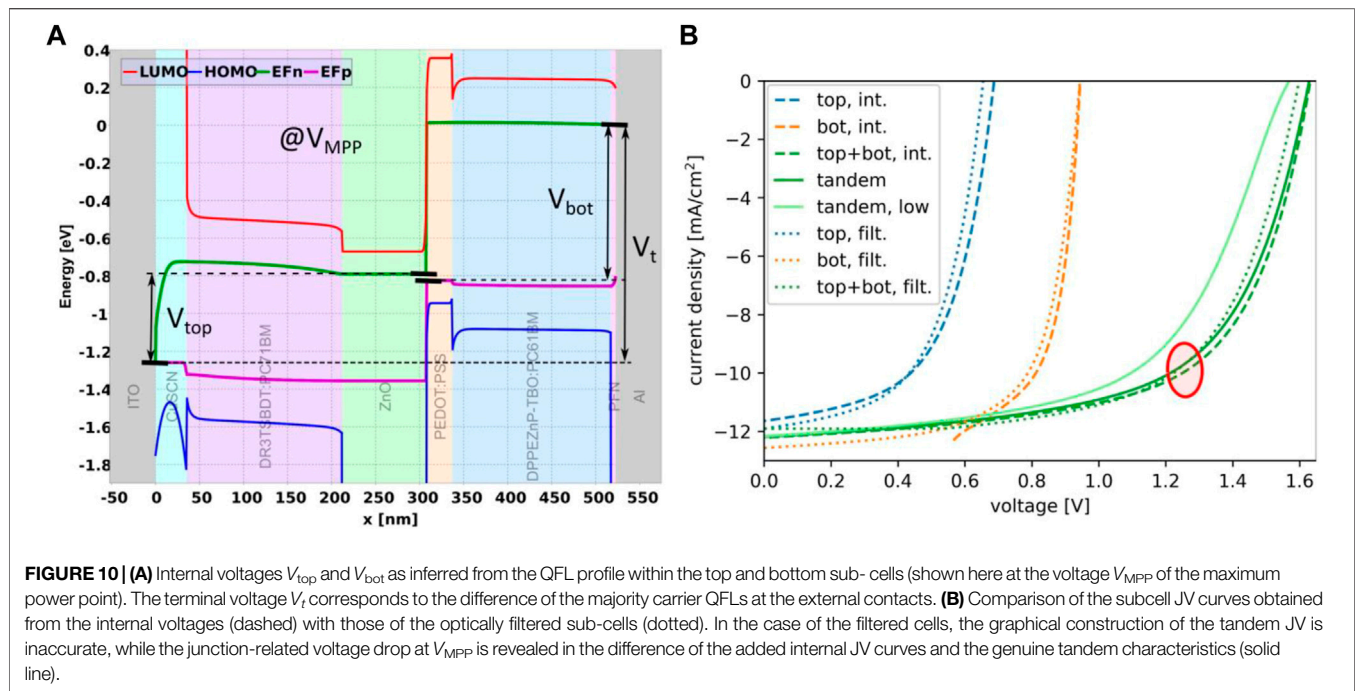


short circuit current ( $J_{SC}$ ) under integration over the AM1.5G flux.

The capability to simulate current flow through the entire device enables us to follow the experimental procedure. This means that we use monochromatic bias light with intensity adjusted to approach AM1.5G generation conditions, such as to establish the appropriate top or bottom limiting situation (i.e., to measure the top-cell EQE we bias the bottom cell and vice versa). **Figure 4** shows (a) the extinction coefficients of top and bottom absorbers with the arrows indicating the monochromatic bias illumination at 470 and 700 nm, respectively, and (b) displays the corresponding generation profiles computed by the optical simulation within Setfos, confirming the targeted regime of current limitation.

The EQE is then obtained in differential form from the additional current induced by the weak mono-chromatic probe beam. In spite of lacking accurate  $nk$ -data in the simulation, there is a rather good agreement with the measured EQE. However, to ensure the internal consistency of the procedure, the short circuit current from the simulation under AM1.5G spectrum is to be compared with the value obtained by integrating the product of EQE and AM1.5G flux over wavelength. Under this spectrum, the tandem device is top limited. We therefore consider the current extracted from the top-cell EQE shown in **Figure 5A** (dashed lines). The small disagreement of the two currents ( $12.22 \text{ mA}/\text{cm}^2$  from EQE vs.  $12.19 \text{ mA}/\text{cm}^2$  from full simulation under AM1.5G flux) is a consequence of the larger reverse top-cell voltage under the





700 nm bias light ( $V_{top} = 0.88$  V) as compared to the situation under AM1.5G illumination ( $V_{top} = 0.53$  V). This is illustrated in **Figures 5B,C** that show the band profiles and quasi-Fermi levels for the two illumination conditions and at vanishing applied voltage. If we correct for this difference by application of a corresponding forward bias voltage  $V = 0.35$  V (**Figure 5D**), the exact same short circuit current is recovered for both EQE (full line in **Figure 5A**) and full spectrum simulations.

The approach is now ready to be used for the comparison of the EQE with the absorbance. **Figure 6** displays the layer-resolved absorbance as a stack plot, overlaid by the bottom/top/tandem EQE curves as yellow dashed/dotted/full lines. Obviously, in the situation considered, carrier extraction is efficient, such that electrical losses are marginal and confined to the long wavelength region. However, this is not obvious from the sub-cell EQEs as extracted from the electrical simulation of the (optically filtered) individual sub-cells (white lines)—an often-used approach (Ding et al., 2011)—which therefore provides only an approximate description of the tandem EQE.

To confirm the validity and accuracy of the approach away from the conditions of ideal charge extraction, we consider a device with low bottom cell IQE due to reduced hole mobility and increased SRH recombination—i.e., reduced mobility-lifetime product  $\mu\tau$ —in the bottom absorber layer, corresponding to devices exhibiting reduced  $J_{SC}$  and fill factor (FF) in their current-voltage characteristics (**Figure 7A**). In this situation, the tandem becomes bottom limited, which is correctly reflected in the bottom cell EQE (**Figure 7B**) and in the corresponding short circuit current (**Figure 7C**), which agree up to numerical inaccuracies. The same applies in a device with low top cell IQE (**Figures 7D–F**).

Since the recombination junction is instrumental for the charge flow in the tandem device, the impact of the charge transfer rate on the EQE is considered next. From the characteristics of the short circuit current vs. hopping rate—shown in **Figures 8A** two different regimes can be identified: In the large to intermediate hopping rate regime, there is no impact of the rate on  $J_{SC}$ . In this situation, the EQE is insensitive to the illumination conditions, as shown in **Figure 8C**. In the low hopping rate regime,  $J_{SC}$  is significantly reduced, and the EQE becomes strongly illumination intensity dependent (**Figure 8B**), as the current is now limited by the charge transfer rate at the recombination junction.

While  $J_{SC}$  is reduced only in the low hopping rate regime,  $V_{OC}$  and FF suffer significant losses already at modest reduction of the hopping rate away from the large hopping regime, as shown in **Figure 9A**. In fact, there is a threshold value for the hopping rate above which no reduction of  $V_{OC}$  can be observed. In that case, one observes a perfect alignment of electron and hole QFLs on either side of the recombination junction, as shown in **Figure 9C**. Below this threshold, a growing discontinuity in the QFL alignment appears, which corresponds to a junction-related voltage drop that is translated directly into a correspondingly reduced  $V_{OC}$  (**Figure 9D**).

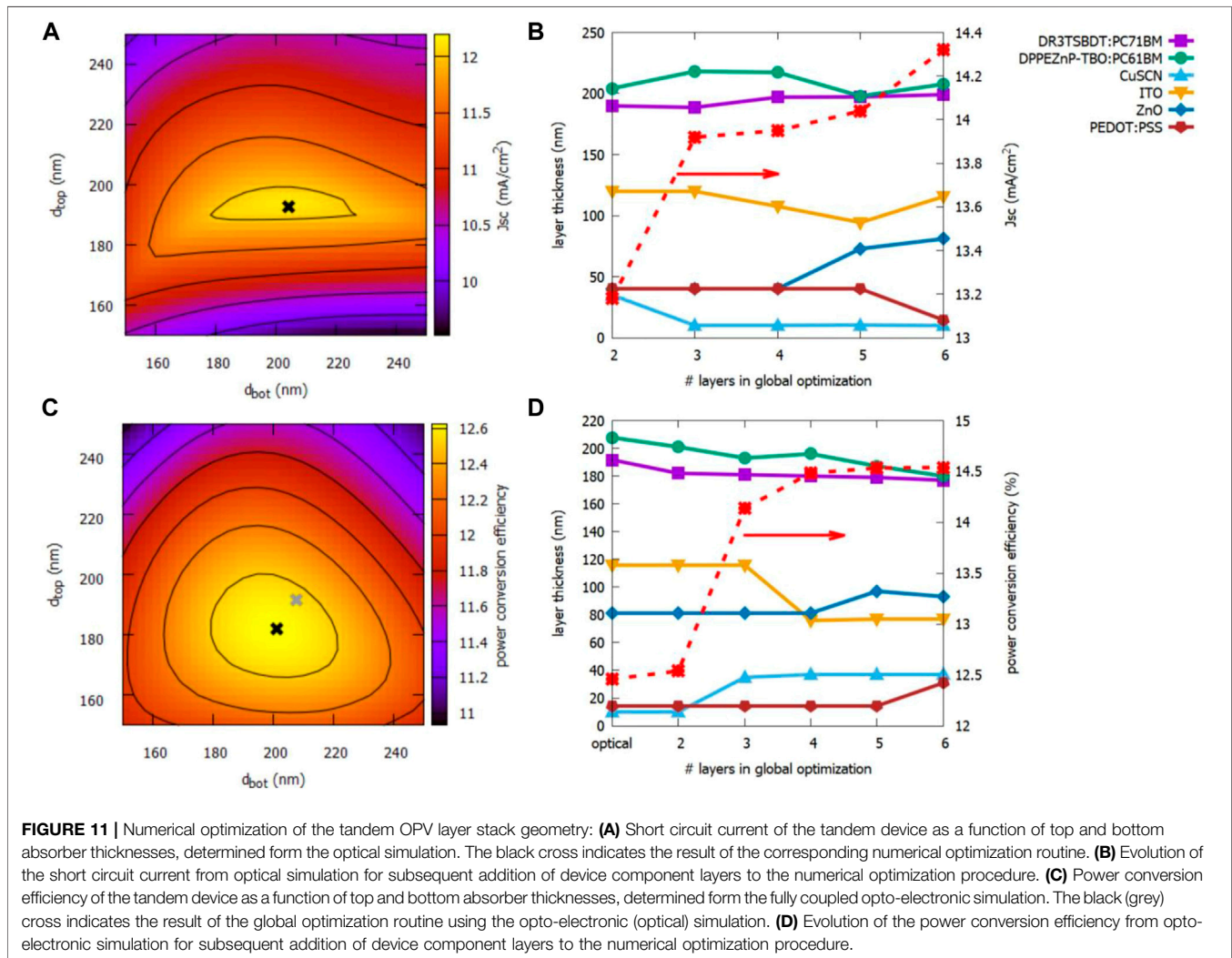
The availability of the QFL profiles throughout the entire device enables the assessment of the internal voltages  $V_{top}$  and  $V_{bot}$  of top and bottom sub-cells. As displayed in **Figure 10**,  $V_{top}$  is the difference in electron QFL at the internal contact formed by the recombination junction and the hole QFL at the top electrode, while  $V_{bot}$  is the difference between, the electron QFL

at the bottom electrode and the hole QFL at the bottom side of the recombination junction. Evaluation of these internal voltages for each value of the external voltage  $V_{app} = V_t$  applied between top and bottom electrode—and which corresponds to a current density via the tandem characteristics—gives the internal current-voltage characteristics of the sub-cells (dashed lines in **Figure 10**). These are to be compared to the sub-cell JV curves obtained from the individual electrical simulation of the optically filtered sub-cells (dotted lines), for which the optics of the full stack is considered, and the PEDOT:PSS is used as top-cell bottom electrode and the ZnO as bottom cell top electrode. While the filtered top-cell characteristics underestimates the internal voltage closed to and beyond the sub-cell MPP, it is found that the internal bottom cell voltage obtained from the QFLs is larger than 0.5 V for all values of the external voltage. The graphical construction of the tandem characteristics—which assumes an ohmic internal contact—underestimates  $V_{OC}$  in the case of filtered sub-cell characteristics. For the internal JV curves from QFLs, the addition of the curves reproduce  $V_{OC}$

correctly, but overestimate the fill factor around MPP. This is consistent with the observation of a finite voltage drop at  $V_{MPP}$  in **Figure 10A** but perfect QFL alignment at  $V_{OC}$  as exhibited in **Figure 9C**. At any rate, the discrepancies between the tandem characteristics obtained from the sub-cell data and the full electrical simulation acquire critical dimensions in the regime of low hopping rates (light solid line).

## 4.2 Optical and Opto-Electronic Optimization

The most common approach to the optimization of tandem solar cell designs is based on the determination of the minimum of the subcell photocurrents as a function of absorber thickness configuration. For the tandem OPV device under consideration, such a  $J_{SC}$  map is shown in **Figure 11A**. Application of a global optimization algorithm together with the optical simulation correctly identifies the optically ideal absorber thickness combination. Adding an increasing number of device component layers to the multi-



parameter optimization routine improves  $J_{SC}$  further (Figure 11B).

Eventually, the coupled simulation approach enables the direct optimization of device efficiency under consideration of both, optical and electrical losses. Again, the optimization as restricted to the absorber layers is first compared to the efficiency map as obtained from a brute force sweep over the absorber layer thicknesses. As displayed in Figure 11C, the location of the optimum configuration (black cross) is again identified correctly by the optimization approach. However, the opto-electronically ideal configuration deviates slightly from the optically ideal thickness combination (grey cross). Similar to the optical case, the opto-electronic optimization is then extended to the full layer stack (Figure 11D). While the initial efficiency obtained from the opto-electronic simulation of the optically optimized stack lies only slightly below the one resulting from the opto-electronic optimization, consideration of additional device components leads to an improvement of the conversion efficiency of about 2% absolute. Interestingly, it is not the absorber thicknesses that change most considerably under consideration of electrical aspects, but the contact and charge transport layers. For the latter, improved transport properties overcompensate optical losses at increased layer thicknesses. The ITO front contact adjusts to this new geometry in order to maintain a large optical density in the absorber.

## 5 CONCLUSION

We present an approach to the full opto-electronic simulation of organic tandem solar cells that is enabled by the explicit consideration of the charge recombination junction. This provides access to characteristics of the electrically coupled

sub-cells such as, external quantum efficiency and internal voltages from quasi-Fermi level profiles under tandem operation, for which prediction based on individual sub-cell characteristics are shown to be prone to inaccuracies. Finally, the coupled approach is demonstrated to allow for device optimization beyond optical considerations, that is, at the maximum power point with the device efficiency as direct target.

## DATA AVAILABILITY STATEMENT

The raw data supporting the conclusion of this article will be made available by the authors, without undue reservation.

## AUTHOR CONTRIBUTIONS

AS, YM, SZ, BB, and BR contributed to the development of the numerical simulation software. UA conceptualized the work, performed the simulations, and wrote the manuscript.

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## SUPPLEMENTARY MATERIAL

The Supplementary Material for this article can be found online at: <https://www.frontiersin.org/articles/10.3389/fphot.2022.891565/full#supplementary-material>

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**Conflict of Interest:** UA, AS, YM, SZ, BB, and BR were employed by Fluxim AG.

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